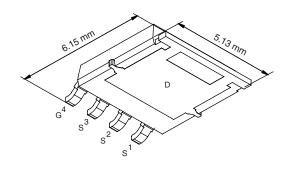


Vishay Siliconix

N-Channel 30-V (D-S) MOSFET

PRODU	CT SUMMARY			
V _{DS} (V)	$R_{DS(on)}(\Omega)$	I _D (A) ^{a, g}	Q _g (Typ.)	
30	0.004 at $V_{GS} = 10 \text{ V}$	32	45 nC	
30	0.005 at $V_{GS} = 4.5 \text{ V}$	32	45110	

PowerPAK® SO-8L Single



Ordering Information: SiJ400DP-T1-GE3 (Lead (Pb)-free and Halogen-free)

FEATURES

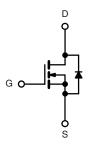
- Halogen-free According to IEC 61249-2-21 Definition
- TrenchFET[®] Power MOSFET
- 100 % R_g Tested
- 100 % UIS Tested
- Compliant to RoHS Directive 2002/95/EC



ROHS COMPLIANT HALOGEN

APPLICATIONS

- POL
- VRM
- DC/DC



N-Channel MOSFET

ABSOLUTE MAXIMUM RATINGS	T _A = 25 °C, unle	ss otherwise not	ed		
Parameter		Symbol	Limit	Unit	
Drain-Source Voltage		V _{DS}	30	V	
Gate-Source Voltage	V _{GS}	± 20			
	T _C = 25 °C		32 ^g		
Continuous Drain Current (T _{.1} = 150 °C)	T _C = 70 °C	I _D	32 ^g		
Continuous Brain Carrent (1) = 100 °C)	T _A = 25 °C	υ Π	26.3 ^{b, c}		
	T _A = 70 °C		21 ^{b, c}	A	
Pulsed Drain Current		I _{DM}	80		
Continuous Source-Drain Diode Current	T _C = 25 °C	I _S	32 ^g		
Continuous Cource Diam Blode Current	T _A = 25 °C	'S	4.5 ^{b, c}		
Single Pulse Avalanche Current	L = 0.1 mH	I _{AS}	40		
Single Pulse Avalanche Energy	L = 0.1 11111	E _{AS}	80	mJ	
	$T_C = 25 ^{\circ}C$		69.4		
Maximum Power Dissipation	T _C = 70 °C	P _D	44.4	w	
Waximum Fower Dissipation	T _A = 25 °C	. п	5.0 ^{b, c}		
	T _A = 70 °C		3.2 ^{b, c}		
Operating Junction and Storage Temperature Ra	T _J , T _{stg}	- 55 to 150	- °C		
Soldering Recommendations (Peak Temperature) ^{d, e}			260		

THERMAL RESISTANCE RATINGS						
Parameter		Symbol	Typical	Maximum	Unit	
Maximum Junction-to-Ambient ^{b, f}	t ≤ 10 s	R _{thJA}	20	25	°C/W	
Maximum Junction-to-Case (Drain)	Steady State	R_{thJC}	1.3	1.8]	

Notes:

- a. Based on T_C = 25 °C.
- b. Surface Mounted on 1" x 1" FR4 board.
- c. t = 10 s.
- d. See Solder Profile (www.vishay.com/ppg?73257). The PowerPAK SO-8L is a leadless package. The end of the lead terminal is exposed copper (not plated) as a result of the singulation process in manufacturing. A solder fillet at the exposed copper tip cannot be guaranteed and is not required to ensure adequate bottom side solder interconnection.
- e. Rework Conditions: manual soldering with a soldering iron is not recommended for leadless components.
- f. Maximum under Steady State conditions is 65 °C/W.
- g. Package limited.

SiJ400DP

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Parameter	Symbol	Test Conditions	Min.	Тур.	Max.	Unit	
Static					I.	•	
Drain-Source Breakdown Voltage	V _{DS}	$V_{GS} = 0 \text{ V}, I_D = 250 \mu\text{A}$	30			V	
V _{DS} Temperature Coefficient	$\Delta V_{DS}/T_{J}$	I _D = 250 μA		28		mV/°C	
V _{GS(th)} Temperature Coefficient	$\Delta V_{GS(th)}/T_J$	I _D = 250 μA		- 6.2			
Gate-Source Threshold Voltage	V _{GS(th)}	$V_{DS} = V_{GS}, I_{D} = 250 \mu A$	1.2		2.5	V	
Gate-Source Leakage	I _{GSS}	$V_{DS} = 0 \text{ V}, V_{GS} = \pm 20 \text{ V}$			± 100	nA	
Zero Gate Voltage Drain Current	I _{DSS}	V _{DS} = 30 V, V _{GS} = 0 V			1		
		V _{DS} = 30 V, V _{GS} = 0 V, T _J = 55 °C			10	μΑ	
On-State Drain Current ^a	I _{D(on)}	$V_{DS} \ge 5 \text{ V}, V_{GS} = 10 \text{ V}$	30			Α	
Drain-Source On-State Resistance ^a	В	$V_{GS} = 10 \text{ V}, I_D = 20 \text{ A}$		0.0033	0.004	Ω	
	R _{DS(on)}	$V_{GS} = 4.5 \text{ V}, I_D = 10 \text{ A}$		0.0041	0.005		
Forward Transconductance ^a	9 _{fs}	$V_{DS} = 10 \text{ V}, I_{D} = 20 \text{ A}$		90		S	
Dynamic ^b							
Input Capacitance	C _{iss}			7765			
Output Capacitance	C _{oss}	$V_{DS} = 15 \text{ V}, V_{GS} = 0 \text{ V}, f = 1 \text{ MHz}$		930		pF	
Reverse Transfer Capacitance	C _{rss}			437			
Total Gate Charge	Q _g V _E	$V_{DS} = 15 \text{ V}, V_{GS} = 10 \text{ V}, I_D = 20 \text{ A}$		100	150	nC	
				45	70		
Gate-Source Charge	Q _{gs}	$V_{DS} = 15 \text{ V}, V_{GS} = 4.5 \text{ V}, I_D = 20 \text{ A}$		18.6			
Gate-Drain Charge	Q_{gd}			9.1			
Gate Resistance	R_g	f = 1 MHz	0.3	0.85	1.7	Ω	
Turn-On Delay Time	t _{d(on)}			16	30	ns	
Rise Time	t _r	V_{DD} = 15 V, R_L = 1.5 Ω		10	20		
Turn-Off Delay Time	t _{d(off)}	$I_D\cong$ 10 A, V_{GEN} = 10 V, R_g = 1 Ω		42	80		
Fall Time	t _f			8	16		
Turn-On Delay Time	t _{d(on)}			48	90		
Rise Time	t _r	V_{DD} = 15 V, R_L = 1.5 Ω		66	120		
Turn-Off Delay Time	t _{d(off)}	$I_D \cong$ 10 A, V_{GEN} = 4.5 V, R_g = 1 Ω		49	90		
Fall Time	t _f			20	40		
Drain-Source Body Diode Characteristi	cs						
Continuous Source-Drain Diode Current	I _S	$T_C = 25 ^{\circ}C$			32	Δ	
Pulse Diode Forward Current ^a	I _{SM}				80	Α	
Body Diode Voltage	V_{SD}	I _S = 3 A		0.73	1.1	V	
Body Diode Reverse Recovery Time	t _{rr}			43	80	ns	
Body Diode Reverse Recovery Charge	Q _{rr}	I _F = 10 A, dl/dt = 100 A/μs, T _J = 25 °C		48	88	nC	
Reverse Recovery Fall Time	t _a	$_{1F} = 10 \text{ A}$, $_{10} = 100 \text{ A/} \mu s$, $_{13} = 25 \text{ C}$		22		20	
Reverse Recovery Rise Time	t _b			21		ns	

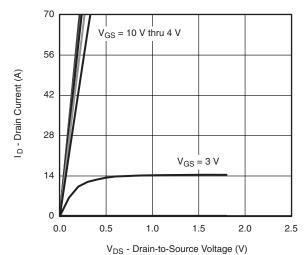
- a. Pulse test; pulse width $\leq 300~\mu s,$ duty cycle $\leq 2~\%.$
- b. Guaranteed by design, not subject to production testing.

Stresses beyond those listed under "Absolute Maximum Ratings" may cause permanent damage to the device. These are stress ratings only, and functional operation of the device at these or any other conditions beyond those indicated in the operational sections of the specifications is not implied. Exposure to absolute maximum rating conditions for extended periods may affect device reliability.

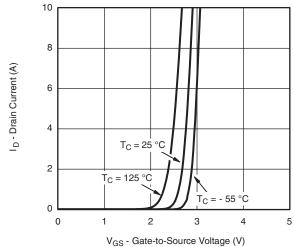


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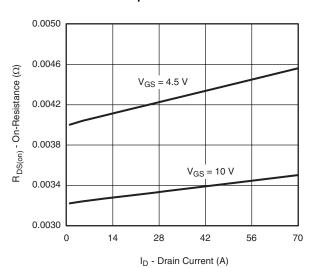
TYPICAL CHARACTERISTICS 25 °C, unless otherwise noted



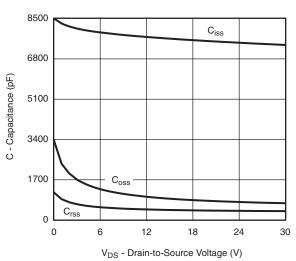
Output Characteristics



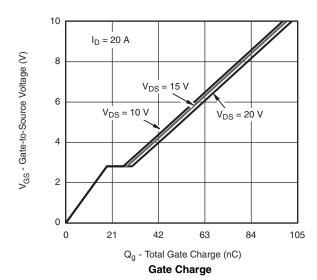
Transfer Characteristics

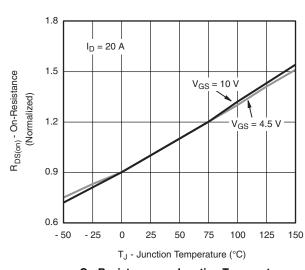


On-Resistance vs. Drain Current and Gate Voltage



Capacitance



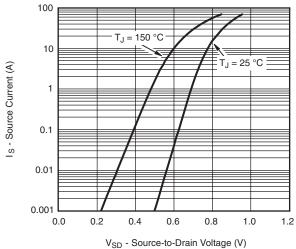


On-Resistance vs. Junction Temperature

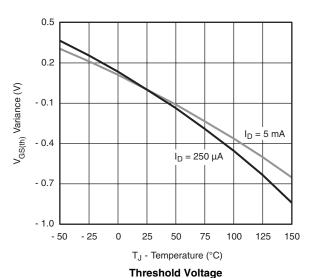
SiJ400DP

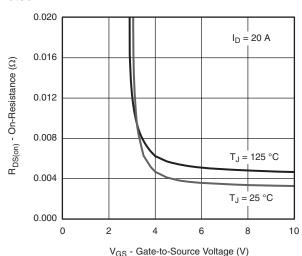
Vishay Siliconix

TYPICAL CHARACTERISTICS 25 °C, unless otherwise noted

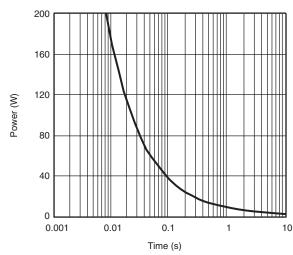


Source-Drain Diode Forward Voltage

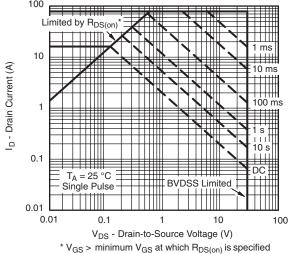




On-Resistance vs. Gate-to-Source Voltage



Single Pulse Power, Junction-to-Ambient

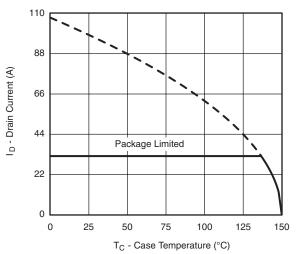


Safe Operating Area, Junction-to-Ambient

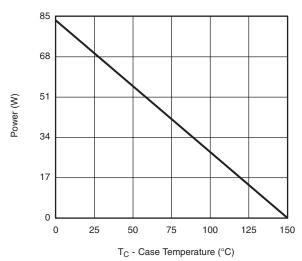


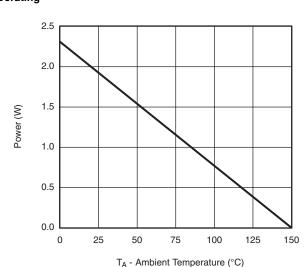
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TYPICAL CHARACTERISTICS 25 °C, unless otherwise noted



Current Derating*





Power, Junction-to-Case

Power, Junction-to-Ambient

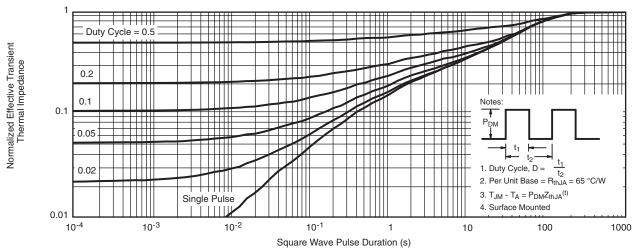
^{*} The power dissipation P_D is based on $T_{J(max)} = 150$ °C, using junction-to-case thermal resistance, and is more useful in settling the upper dissipation limit for cases where additional heatsinking is used. It is used to determine the current rating, when this rating falls below the package limit.

SiJ400DP

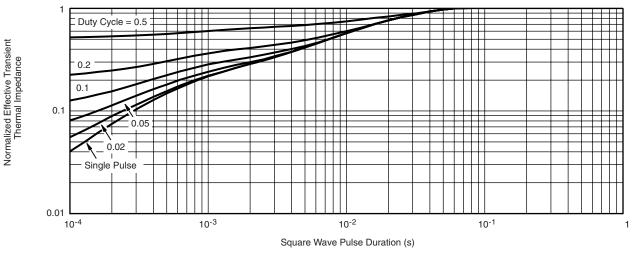
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TYPICAL CHARACTERISTICS 25 °C, unless otherwise noted



Normalized Thermal Transient Impedance, Junction-to-Ambient



Normalized Thermal Transient Impedance, Junction-to-Case

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